

N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)		
40	0.0012 at V _{GS} = 10 V	180	125 nC		
	0.0016 at $V_{GS} = 4.5 \text{ V}$	150	123110		

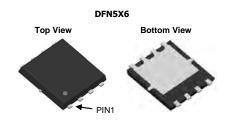
FEATURES

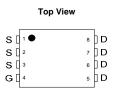
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

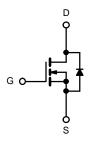


APPLICATIONS

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ss otherwise no	ted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	± 20		
Continuous Drain Current (T _J = 175 °C)	T _C = 25 °C		180 ^{a, e}		
	T _C = 70 °C	I _D	158 ^e		
	T _A = 25 °C	'D	40 ^{b, c}	A	
	T _A = 70 °C		28.9 ^{b, c}		
Pulsed Drain Current		I _{DM}	420		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	46		
Single Pulse Avalanche Energy	L = 0.1 IIIA	E _{AS}	580	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	180 ^{a, e}	A	
	T _A = 25 °C	'S	5.95 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C		120 ^a		
	T _C = 70 °C	P _D	84	W	
	T _A = 25 °C	υ .	4.15 ^{b, c}	VV	
	T _A = 70 °C		2.91 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	14	18	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.45	0.7		

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static			•				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40		V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J _ 250^		35		m\//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{D} = 250 \mu A$		- 5.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 32 V, V _{GS} = 0 V			1		
		V _{DS} = 32 V, V _{GS} = 0 V, T _J = 55 °C			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	180			Α	
D : 0	В	V _{GS} = 10 V, I _D = 30 A		0.0012	0.0015	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0015	0.0019		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		80		S	
Dynamic ^b			•				
Input Capacitance	C _{iss}			5885		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		3842			
Reverse Transfer Capacitance	C _{rss}			160			
Total Gate Charge	Q _g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		125		nC	
				57.3			
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		18			
Gate-Drain Charge	Q_{gd}			13			
Gate Resistance	R_g	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t _{d(on)}			14	22	- ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.555 Ω		10	16		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 30A$, $V_{GEN} = 10$ V, $R_g = 1$ Ω		56	85		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			12	20		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		150	220		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		55	83		
Fall Time	t _f			12	18		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			180	۸	
Pulse Diode Forward Current ^a	I _{SM}				420	A	
Body Diode Voltage	V_{SD}	I _S = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			35	58	ns	
Body Diode Reverse Recovery Charge Qrr I = 20 A di/dt = 1		L = 20 A di/dt = 100 A/us T = 25 °C		90.2	125	nC	
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$		27			
Reverse Recovery Rise Time	t _b			25		ns	

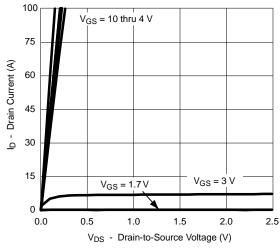
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

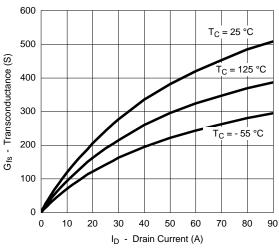
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



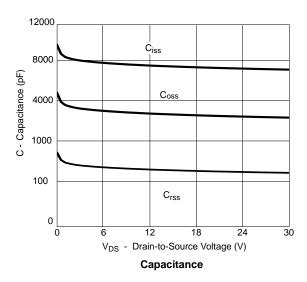
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

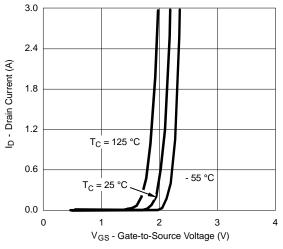


Output Characteristics

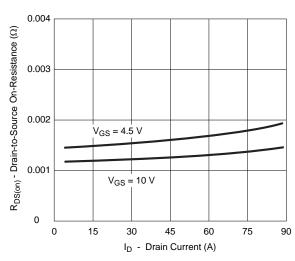


Transconductance

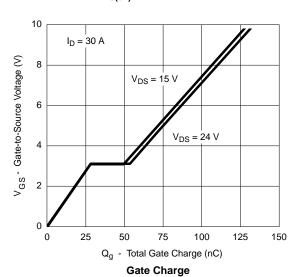




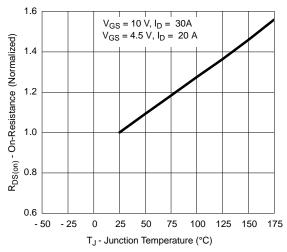
Transfer Characteristics



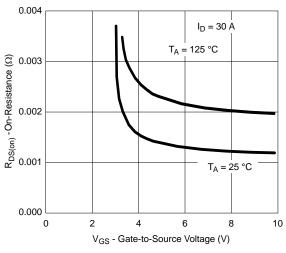
R_{DS(on)} vs. Drain Current



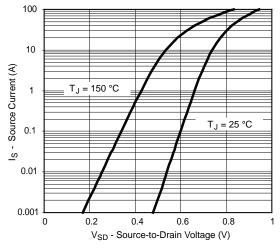
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



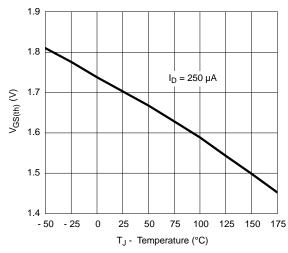
On-Resistance vs. Junction Temperature



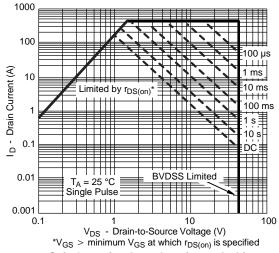
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature

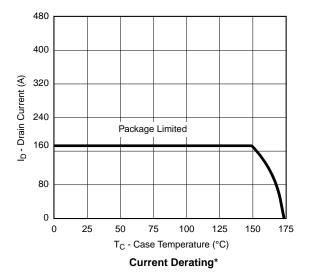


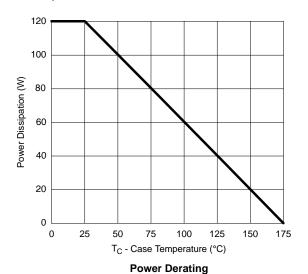
Threshold Voltage



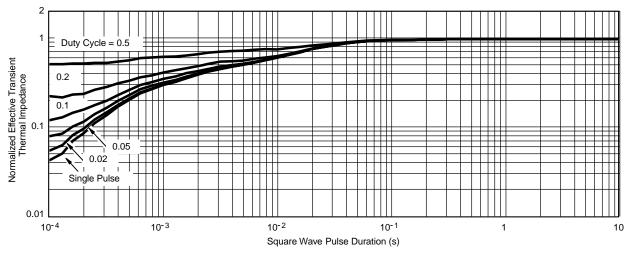
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





* The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case





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